

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/568,683	TANAKA ET AL.	
Examiner	Art Unit	
Pam N. Kaskar	1702	

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Class	Subclass	Date	Examiner

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Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Updated search	1/16/2009	RK		
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